EE445L – Lab 9: Temperature Data Acquisition System

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1.0 OBJECTIVE

The objective of this lab is to design, build and test a digital thermometer that can measure the range of 10 to 40 °C using an ADC converter on the TM4C123. Educationally, we are learning how to create a temperature acquisition circuit using a Whitestone Bridge circuit, instrumentation amplifier, and a butterworth low-pass filter as well as how to choose a sampling frequency (Nyquist Theorem, Valvano Postulate) and a cutoff frequency for the filter.

2.0 HARDWARE DESIGN

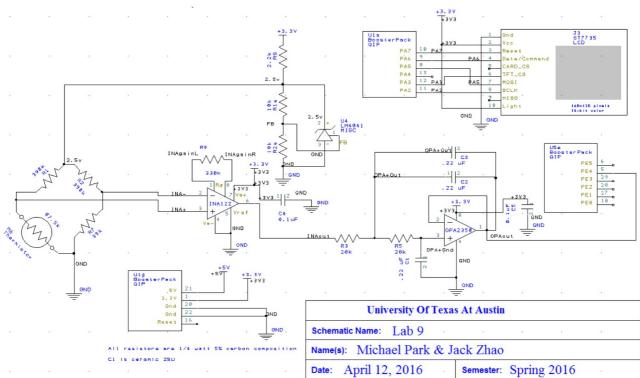


Figure 1: Circuit diagram of the thermistor interface

```
3.0 SOFTWARE DESIGN
1) Calibration data (procedure 5 and the calib.h file)
// ****** Calib.h *********
// Michael Park, Jack Zhao
// Date Created: 04/09/2016
// Includes prototypes for functions Temp Calibration
// Lab Number: 16340
// TA: Mahesh Sriniyasan
// Last Revised: 04/15/2016
uint16 t const ADCTable[53]={0,184,226,269,313,358,404,452,501,550,601,
   654.707.762.818.876.935.995.1057.1120.1184.
   1251,1318,1388,1459,1531,1605,1681,1759,1838,1919,
   2002,2086,2173,2261,2351,2443,2537,2632,2730,2829,
   2931,3034,3140,3247,3356,3467,3580,3695,3812,3931,4052,4096};
uint16 t const TempTable[53]={4000,4000,3940,3880,3820,3760,3700,3640,3600,3550,3510,
   3510,3500,3490,3480,3470,3450,3400,3350,3300,3250,
   3200,3000,2800,2680,2560,2450,2380,2370,2369,2350,
   2330,2300,2280,2270,2260,2200,1840,1780,1720,1660,
   1600,1540,1480,1420,1360,1300,1240,1180,1120,1060,1000,1000};
2) Low level ADC interface (ADC.c and ADC.h files)
// ***** ADCSWTrigger.c **********
// Michael Park, Jack Zhao
// Date Created: 04/09/2016
// Includes function definition for ADC
// Lab Number: 16340
// TA: Mahesh Srinivasan
// Last Revised: 04/15/2016
// ADCSWTrigger.c
// Runs on LM4F120/TM4C123
// Provide functions that initialize ADC0 SS3 to be triggered by
// software and trigger a conversion, wait for it to finish,
// and return the result.
// Daniel Valvano
// May 2, 2015
#include <stdint.h>
#include "ADCSWTrigger.h"
#include "../inc/tm4c123gh6pm.h"
void DisableInterrupts(void); // Disable interrupts
void EnableInterrupts(void); // Enable interrupts
long StartCritical (void); // previous I bit, disable interrupts
void EndCritical(long sr); // restore I bit to previous value
void WaitForInterrupt(void); // low power mode
uint32 t ADCValue;
```

```
void ADC0 InitSWTriggerSeq3 Ch9(uint32 t period){
      volatile uint32 t delay;
                   // 1) activate clock for Port E
 SYSCTL RCGCGPIO R = 0x10;
 while((SYSCTL PRGPIO R&0x10) != 0x10){};
 GPIO PORTE DIR R &= \sim 0x10;
                                   // 2) make PE4 input
 GPIO PORTE AFSEL R \models 0x10; // 3) enable alternate function on PE4
 GPIO PORTE DEN R &= \sim 0x10; // 4) disable digital I/O on PE4
 GPIO PORTE AMSEL R = 0x10; // 5) enable analog functionality on PE4
 SYSCTL RCGCADC R = 0x0001; // 7) activate ADC0
 while((SYSCTL PRADC R&0x0001) != 0x0001){}; // good code, but not yet implemented in
simulator
 ADC0 PC R &= \sim 0xF;
                            // 7) clear max sample rate field
ADC0 PC R = 0x1; // configure for 125K samples/sec
 ADC0 SSPRI R = 0x0123; // 8) Sequencer 3 is highest priority
                                                           // activate timer0
      SYSCTL RCGCTIMER R = 0x01;
      delay = SYSCTL RCGCGPIO R;
      TIMER0 CTL R = 0x000000000;
                                                    //disable timer0A for setup
      TIMERO_CTL_R = 0x00000020;
                                                    //enable timer0A trigger to ADC
      TIMER0 CFG R = 0;
                                                                               //configure
for 32-bit timer mode
      TIMER0 TAMR R = 0x000000002;
                                                    //configures for periodic mode
      TIMER0 TAPR R = 0;
                                                                        //prescale value for
trigger
      TIMER0 TAILR R = period-1;
                                                    //start value for trigger
      TIMER0 IMR R = 0x000000000;
                                                    //disable all interrupts
      TIMER0 CTL R = 0x00000001;
                                                    //enable timer0A 32-b periodic
 ADC0 ACTSS R &= \sim 0 \times 00008;
                                  // 9) disable sample sequencer 3
      ADC0 EMUX R = (ADC0 EMUX R \& 0xFFFF0FFF) + 0x5000; //timer trigger
 //ADC0 EMUX R &= \sim 0 \times F000;
                                   // 10) seq3 is software trigger
 ADC0 SSMUX3 R &= \sim 0 \times 000F:
                                   // 11) clear SS3 field
 ADC0 SSMUX3 R += 9;
                               // set channel
 ADC0 SSCTL3 R = 0x0006;
                                // 12) no TS0 D0, yes IE0 END0
                                // 13) disable SS3 interrupts
 ADC0 IM R &= \sim 0 \times 00008;
 ADC0 ACTSS R = 0x0008;
                                // 14) enable sample sequencer 3
      NVIC PRI4 R = (NVIC PRI4 R \& 0xFFFF00FF) | 0x00004000; //priority 2
      NVIC_EN0 R = 1 << 17;
                                                                        //enable interrupt
17 in NVIC
      EnableInterrupts();
}
//-----ADC0 InSeg3-----
// Busy-wait Analog to digital conversion
```

```
// Input: none
// Output: 12-bit result of ADC conversion
uint32 t ADC0 InSeq3(void){ uint32 t result;
 ADC0 PSSI R = 0x0008;
                                // 1) initiate SS3
 while((ADC0 RIS R\&0x08)==0){}; // 2) wait for conversion done
  // if you have an A0-A3 revision number, you need to add an 8 usec wait here
 result = ADC0 SSFIFO3 R&0xFFF; // 3) read result
 ADC0 ISC R = 0x0008;
                             // 4) acknowledge completion
 return result;
}
//-----ADC0Seg3 Handler-----
// Interrupts on adc change
// Input: none
// Output: none
void ADC0Seq3 Handler(void){
// ADC0 PSSI R = 0x0008;
                                 // 1) initiate SS3
// while((ADC0 RIS R&0x08)==0){}; // 2) wait for conversion done
// if you have an A0-A3 revision number, you need to add an 8 usec wait here
      ADC0 ISC R = 0x08;
                                   // 4) acknowledge completion
 ADCValue = ADC0 SSFIFO3 R&0xFFF; // 3) read result
 ADC0 ISC R = 0x0008;
                               // 4) acknowledge completion
//----returnADC-----
// return adc value
// Input: none
// Output: ADC
uint32 t returnADC(void){
      return ADCValue;
}
// ***** ADCSWTrigger.h **********
// Michael Park, Jack Zhao
// Date Created: 04/09/2016
// Includes prototypes for functions in ADCSWTrigger.c
// Lab Number: 16340
// TA: Mahesh Srinivasan
// Last Revised: 04/15/2016
// ADCSWTrigger.h
// Runs on LM4F120/TM4C123
// Provide functions that initialize ADC0 SS3 to be triggered by
// software and trigger a conversion, wait for it to finish,
// and return the result.
// Daniel Valvano
// May 2, 2015
void ADC0 InitSWTriggerSeq3 Ch9(uint32 t period);
//-----ADC0 InSeg3-----
// Busy-wait Analog to digital conversion
```

```
// Input: none
// Output: 12-bit result of ADC conversion
uint32 t ADC0 InSeq3(void);
void ADC0Seq3 Handler(void);
uint32 t returnADC(void);
3) Main program used to measure temperature
// ****** Main.c *********
// Michael Park, Jack Zhao
// Date Created: 04/9/2016
// Main program functions
// Lab Number: 16340
// TA: Mahesh Srinivasan
// Last Revised: 04/15/2016
// main c
// Runs on LM4F120/TM4C123
// UART runs at 115,200 baud rate
// Daniel Valvano
// May 3, 2015
#include <stdio.h>
#include <stdint.h> // C99 variable types
#include "ADCSWTrigger.h"
#include "uart.h"
#include "PLL.h"
#include "ST7735.h"
#include "Timer1.h"
/* Assuming 80MHz Bus
1khz: 80000
100hz(Valvano Postulate): 800000
500hz(Nyquist Theorom): 160000
2khz(Aliased): 40000 */
#define ADCfreq 80000
void DisableInterrupts(void); // Disable interrupts
void EnableInterrupts(void); // Enable interrupts
long StartCritical (void); // previous I bit, disable interrupts
void EndCritical(long sr); // restore I bit to previous value
void WaitForInterrupt(void); // low power mode
void periodicADC(void);
int32 t ADCTempConvert(uint32 t ADC);
int32 t Interpolate(int lower, int higher, int32 t ADC);
void lcdFixed(int32 t temp);
volatile uint32 t counter;
volatile int32 t data[100];
int main(void){
       counter=0;
```

```
PLL Init(Bus80MHz); // 80 MHz
 ST7735 InitR(INITR REDTAB);
                                                         // Init PORTA and LCD
initializations
 ST7735 FillScreen(ST7735 WHITE);
 ST7735 FillRect(0, 0, 128, 50, ST7735 BLACK);
      ST7735 PlotClear(0, 4000);
UART Init();
                   // initialize UART device
ADC0 InitSWTriggerSeq3 Ch9(4000000);//4000000
      Timer1 Init(*periodicADC,800);//4000000
EnableInterrupts();
      while(1){};
}
void periodicADC(void){
      uint32 t ADCval;
      uint32 t TEMPval;
      //ADCval=returnADC();
      ADCval=ADC0 InSeq3();
      //TEMPval=ADCTempConvert(ADCval);
      //UART OutUDec(TEMPval);
      //prelab
      //data[counter]=TEMPval;
            data[counter]=ADC0 InSeq3();
      if(counter >= 100){
            for(int k=0; k<20; k++)
                   UART OutString("\n\r");
            UART OutString("\n\r-----");
            for(int j=0; j<100; j++){
                   UART OutString("\n\r");
                   UART OutUDec(i);
                  UART_OutString("): ----- ADC data =");
                   UART OutUDec(data[counter]):
            while(1)\{\};
      counter++;
      */
      //end prelab
      TEMPval=ADCTempConvert(ADCval);
      lcdFixed(TEMPval);
      ST7735 SetCursor(0,2);
      ST7735 OutString("ADC=");
      ST7735 OutUDec(ADCval);
      ST7735 PlotNextErase();
```

```
ST7735 PlotPoint(TEMPval);
      ST7735_PlotNext();
      ST7735 PlotNextErase();
int32 t ADCTempConvert(uint32 t ADC){
      int point=0;
      while(ADCTable[point]<ADC){</pre>
             point++;
      if(ADCTable[point]==ADC){
             return TempTable[point];
      return Interpolate(point-1,point,ADC);
int32 t Interpolate(int lower, int higher, int32 t ADC){
      double tempLower=TempTable[lower];
      double tempHigher=TempTable[higher];
      double adcLower=ADCTable[lower];
      double adcHigher=ADCTable[higher];
      double currentADC=ADC;
      double result= tempLower+ (tempHigher-tempLower) * ((currentADC-adcLower)/
(adcHigher-adcLower));
      return (int32 t) result;
void lcdFixed(int32 t temp){
      char out[6];
      ST7735 SetCursor(0,0);
      ST7735 OutString("Thermometer");
      ST7735 SetCursor(0,1);
      ST7735_OutString("T=");
      if(temp>99999){
             ST7735 DrawString(0,0,"***.**",ST7735 WHITE);
      else{
             int before=temp/100:
             int after=temp%100;
             sprintf(out,"%d.%d",before,after);
             ST7735 OutString(out);
             ST7735 OutString(" C");
}
```

4.0 MEASUREMENT DATA

1) Sketch three waveforms (procedure 1)

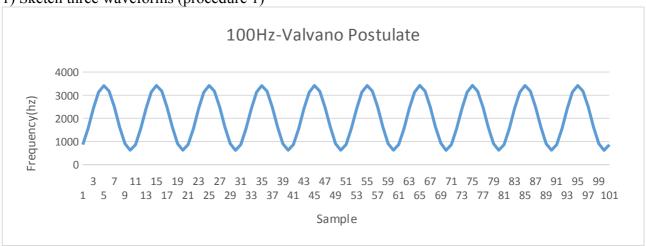


Figure 2: Valvano Postulate Sine Wave

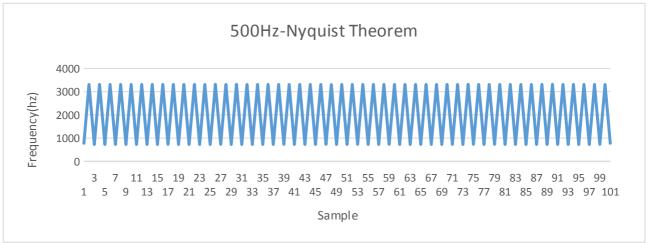


Figure 3: Nyquist Theorem Sine Wave

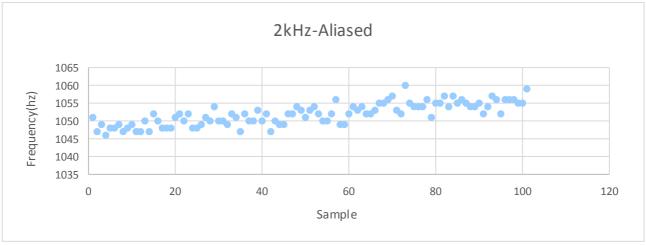


Figure 4: Aliased Sine Wave

The Valvano postulate specifies to sample at 10x the frequency and the Nyquist Theorem states to sample at 2x the frequency. The Aliased is sampling slower than the frequency. From the graphs, we can see the Valvano postulate graph display a much more defined graph and the Nyquist theorem just capture key points on the frequency. The Aliased graph does not completely capture the sine wave.

2) Static circuit performance (procedure 2)

181k	3.04V
127k	2.08V
100k	1.52V
54k	640 mV
disconnected	3.24 V
shorted	500mV

3) Dynamic circuit performance (procedure 3)

input sinewave amp	100mV-560mV	
output sinewave	561mV-3.14V	
un amplified	amplified	Gain
400mV	1.60V	4
472mV	1.72V	3.64
456mV	1.80V	3.94
580mV	2.60V	4.48
640mV	2.96V	4.625
720mV	3.04V	4.22
728mV	3.08V	4.23
750mV	3.10V	4.13
580mV	3.16V	5.44
520mV	3.16V	6.07

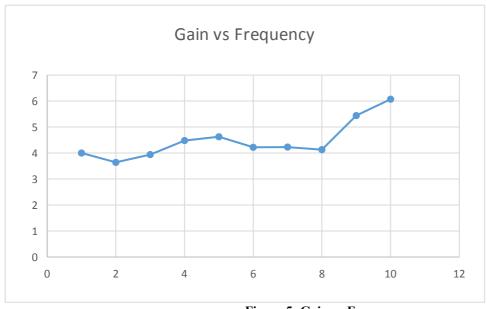


Figure 5: Gain vs Frequency

4) Accuracy (procedure 6)

Measured	Fluke
23.46	23.45
23.46	23.47
23.45	23.41
23.48	23.44
23.47	23.44

avg error: .026

5) Reproducibility (procedure 7)

23.46

23.46

23.45

23.48

23.47

23.48

23.48

23.46

23.45

23.47

Standard Deviation: .01174

S: .00014

5.0 ANALYSIS AND DISCUSSION

1) What is the Nyquist theorem and how does it apply to this lab?

Nyquist theorem states that the sampling frequency should be at least twice the frequency of the signal to be sampled. In this lab, the frequency component of the measured signal was between $0-10~\mathrm{Hz}$. Therefore the sampling frequency of our system had to be at least 20 Hz.

2) Explain the difference between resolution and accuracy?

Resolution is the smallest change in the input parameter that can be reliably detected by the measurement. Accuracy ((Actual – Ideal) / Ideal) is a measure of how close our instrument measures the desired parameter referred to the NIST.

3) Derive an equation to relate reproducibility and precision of the thermometer.

Reproducibility is a parameter that specifies whether the instrument has equal outputs give identical inputs over some period of time. This parameter can be expressed as the full range of output results given a fixed input. Thus, the precision of the thermometer can be expressed as the following equation.

Precision = full range of output results at fixed input / resolution of the thermometer.

4) What is the purpose of the LPF?

The purpose of the LPF is to remove high frequency noise to improve signal to noise ratio. In this lab, our frequency of interest was 0 - 10Hz (low frequency). Thus using a butterworth LPF(Anti-ailiasing filter) restricted the bandwith of the signal, and as a result, increased the signal to noise ratio (SNR).

5) If the R versus T curve of the thermistor is so nonlinear, why does the voltage versus temperature curve look so linear?

The R versus T curve of the thermistor is nonlinear becuase the transducer(thermistor) is nonlinear. However, the bridge circuit used for the thermistor is also nonlinear as shown by the equation (2.5*Rt)/(R1+Rt). Therefore, because both the transducer and the circuit are nonlinear, the final outcome (voltage vs temperature curve) becomes much closer to being linear.

6) There are four methods (a,b,c,d) listed in the 4) Software Conversion section of methods and constraints. For one of the methods you did not implement, give reasons why your method is better, and give reasons why this alternative method would have been better.

We used a small table lookup (\approx 50 entries) with linear interpolation in between instead of a large table lookup (one entry for each ADC value). Small table lookup takes up less memory space than the large table lookup. On the other hand, large table lookup is more accurate because it does not use linear interpolation.